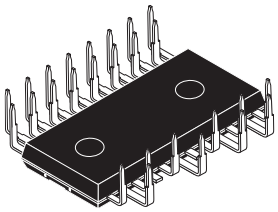
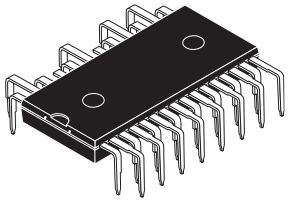
STIPN2M50-H

Datasheet

SLLIMM-nano IPM, 3-phase inverter, 2 A, 1.7 Ω max., 500 V MOSFET





NDIP-26L

Features

- IPM 2 A, 500 V, $R_{DS(on)}$ = 1.7 Ω, 3-phase MOSFET inverter bridge including control ICs for gate driving
- Optimized for low electromagnetic interference
- 3.3 V, 5 V, 15 V CMOS/TTL input comparators with hysteresis and pull-down/ pull-up resistors
- Undervoltage lockout
- Internal bootstrap diode
- Interlocking function
- Shutdown function
- Comparator for fault protection against overtemperature and overcurrent
- Op-amp for advanced current sensing
- Optimized pinout for easy board layout
- Up to ±2 kV ESD protection (HBM C = 100 pF, R = 1.5 kΩ)

Applications

- 3-phase inverters for motor drives
- Dish washers
- Refrigerator compressors
- Air-conditioning fans
- Draining and recirculation pumps

Description

This SLLIMM (small low-loss intelligent molded module) nano provides a compact, high-performance AC motor drive in a simple, rugged design. It is composed of six MOSFETs and three half-bridge HVICs for gate driving, providing low electromagnetic interference (EMI) characteristics with optimized switching speed. The package is optimized for thermal performance and compactness in built-in motor applications, or other low power applications where assembly space is limited. This IPM includes an operational amplifier, completely uncommitted, and a comparator that can be used to design a fast and efficient protection circuit. SLLIMM is a trademark of STMicroelectronics.

Product status link
STIPN2M50-H

Product summary	
Order code	STIPN2M50-H
Marking	IPN2M50-H
Package	NDIP-26L
Packing	Tube

1 Internal schematic diagram and pin configuration

Figure 1. Internal schematic diagram

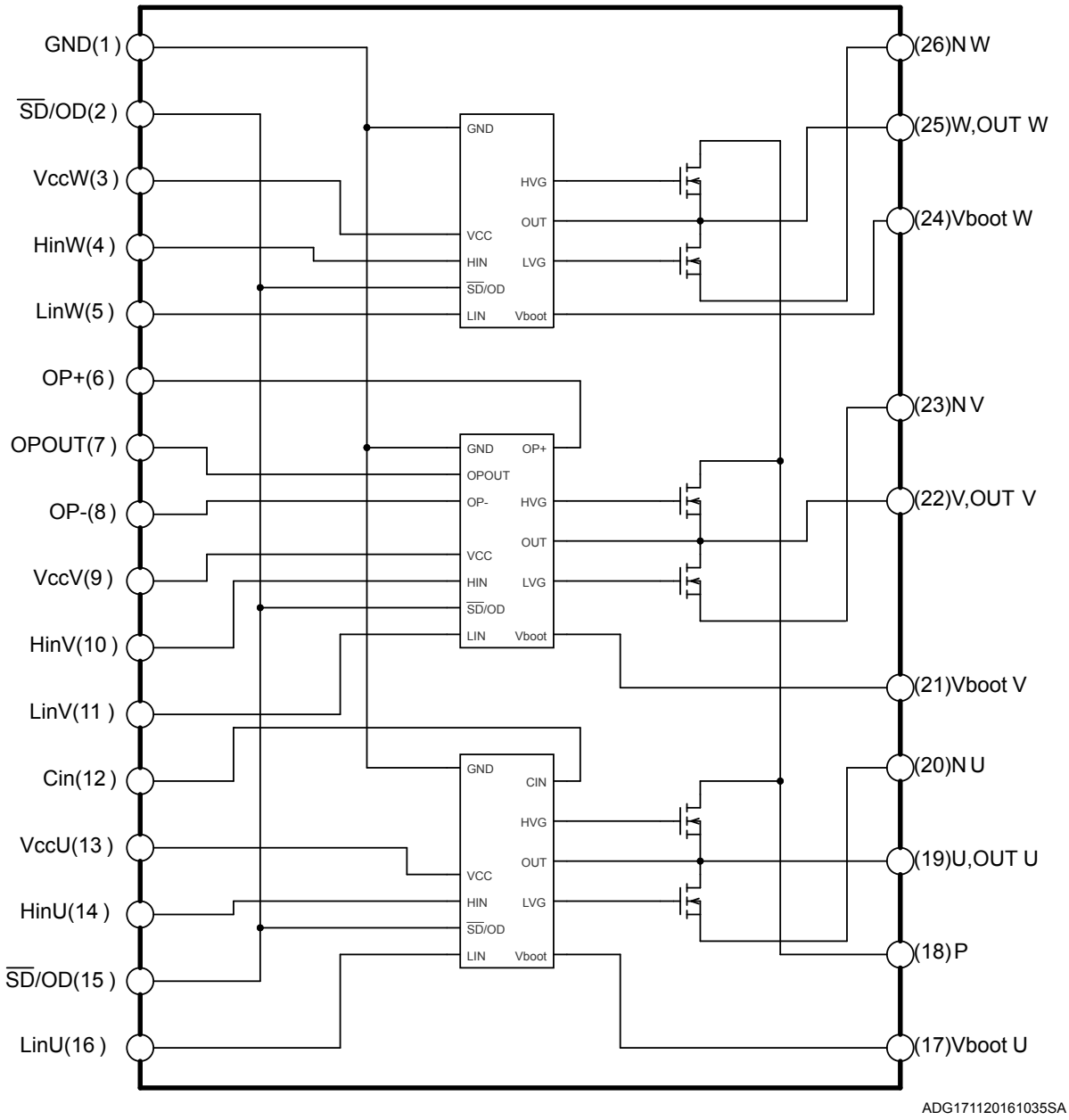
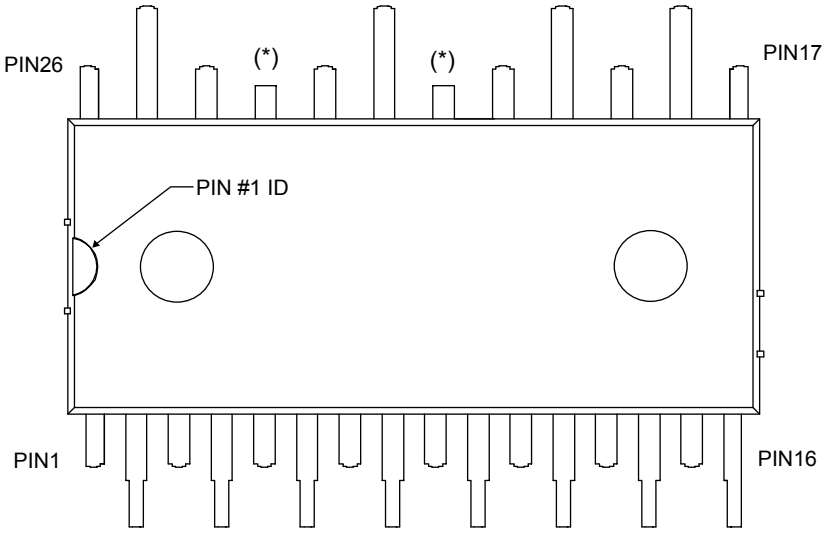


Table 1. Pin description

Pin	Symbol	Description
1	GND	Ground
2	$\overline{SD}$/OD	Shutdown logic input (active low) / open-drain (comparator output)
3	V_{CC} W	Low voltage power supply W phase
4	HIN W	High-side logic input for W phase
5	LIN W	Low-side logic input for W phase
6	OP+	Op-amp non inverting input
7	OP_{OUT}	Op-amp output
8	OP-	Op-amp inverting input
9	V_{CC} V	Low voltage power supply V phase
10	HIN V	High-side logic input for V phase
11	LIN V	Low-side logic input for V phase
12	CIN	Comparator input
13	V_{CC} U	Low voltage power supply for U phase
14	HIN U	High-side logic input for U phase
15	$\overline{SD}$/OD	Shutdown logic input (active low) / open-drain (comparator output)
16	LIN U	Low-side logic input for U phase
17	V_{BOOT} U	Bootstrap voltage for U phase
18	P	Positive DC input
19	U, OUT_U	U phase output
20	N_U	Negative DC input for U phase
21	V_{BOOT} V	Bootstrap voltage for V phase
22	V, OUT_V	V phase output
23	N_V	Negative DC input for V phase
24	V_{BOOT} W	Bootstrap voltage for W phase
25	W, OUT_W	W phase output
26	N_W	Negative DC input for W phase

Figure 2. Pin layout (top view)



(*) Dummy pin internally connected to P (positive DC input).

AM09368V1

2 Electrical ratings

2.1 Absolute maximum ratings

Table 2. Inverter part

Symbol	Parameter	Value	Unit
V_{DSS}	MOSFET blocking voltage (or drain-source voltage) for each MOSFET (V_{IN}[1] = 0 V)	500	V
$\pm I_D$	Continuous drain current each MOSFET (T_C = 25 °C)	2	A
$\pm I_{DP}$[2]	Peak drain current each MOSFET (less than 1 ms)	4	A
P_{TOT}	Total power dissipation for each MOSFET (T_C = 25 °C)	11.8	W

1. *Applied between HINi, LINi and GND for i = U, V, W.*
2. *Pulse width limited by max. junction temperature.*

Table 3. Control part

Symbol	Parameter	Min.	Max.	Unit
V_{OUT}	Output voltage applied between OUT_U, OUT_V, OUT_W - GND	V_{boot} - 21	V_{boot} + 0.3	V
V_{CC}	Low voltage power supply	- 0.3	21	V
V_{CIN}	Comparator input voltage	- 0.3	V_{CC} + 0.3	V
V_{op+}	Op-amp non-inverting input	- 0.3	V_{CC} + 0.3	V
V_{op-}	Op-amp inverting input	- 0.3	V_{CC} + 0.3	V
V_{boot}	Bootstrap voltage	- 0.3	620	V
V_{IN}	Logic input voltage applied between HIN, LIN and GND	- 0.3	15	V
$V_{\overline{SD}/OD}$	Open-drain voltage	- 0.3	15	V
dV_{OUT}/dt	Allowed output slew rate		50	V/ns

Table 4. Total system

Symbol	Parameter	Value	Unit
V_{ISO}	Isolation withstand voltage applied on each pin and heatsink plate (AC voltage, t = 60 s)	1000	V_{rms}
T_J	Power chip operating junction temperature	-40 to 150	°C
T_C	Module case operation temperature	-40 to 125	°C

2.2 Thermal data

Table 5. Thermal data

Symbol	Parameter	Value	Unit
$R_{th(j-c)}$	Thermal resistance junction-case single MOSFET	10.6	°C/W
$R_{th(j-a)}$	Thermal resistance junction-ambient (per module)	22	°C/W

3 Electrical characteristics

T_J = 25 °C unless otherwise specified.

3.1 Inverter part

Table 6. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{DSS}	Zero-gate voltage drain current	V_{DS} = 500 V, V_{CC} = 15 V, V_{Boot} = 15 V			1	mA
$V_{(BR)DSS}$	Drain-source breakdown voltage	V_{CC} = V_{boot} = 15 V, V_{IN} (1) = 0 V, I_D = 1 mA	500			V
$R_{DS(on)}$	Static drain source turn-on resistance	V_{CC} = V_{boot} = 15 V, V_{IN} (1) = 0 to 5 V, I_D = 1.2 A		1.5	1.7	Ω
V_{SD}	Drain-source diode forward voltage	V_{IN} (1) = 0 “logic state”, I_D = 2 A		0.9	1.6	V

1. *Applied between HINx, LINx and GND for x = U, V, W.*

Table 7. Inductive load switching time and energy

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t_{on} (1)	Turn-on time	V_{DD} = 300 V, V_{CC} = V_{boot} = 15 V, V_{IN} (2) = 0 to 5 V, I_C = 1.2 A (see Figure 4. Switching time definition)	-	267	-	ns
$t_{c(on)}$ (1)	Crossover time (on)		-	153	-	
t_{off} (1)	Turn-off time		-	265	-	
$t_{c(off)}$ (1)	Crossover time (off)		-	46	-	
t_{rr}	Reverse recovery time		-	192	-	
E_{on}	Turn-on switching energy		-	61	-	µJ
E_{off}	Turn-off switching energy		-	4	-	

1. *t_{on} and t_{off} include the propagation delay time of the internal drive. $t_{c(on)}$ and $t_{c(off)}$ are the switching time of MOSFET itself under the internally given gate driving conditions.*
2. *Applied between HINx, LINx and GND for x = U, V, W.*

Figure 3. **Switching time test circuit**

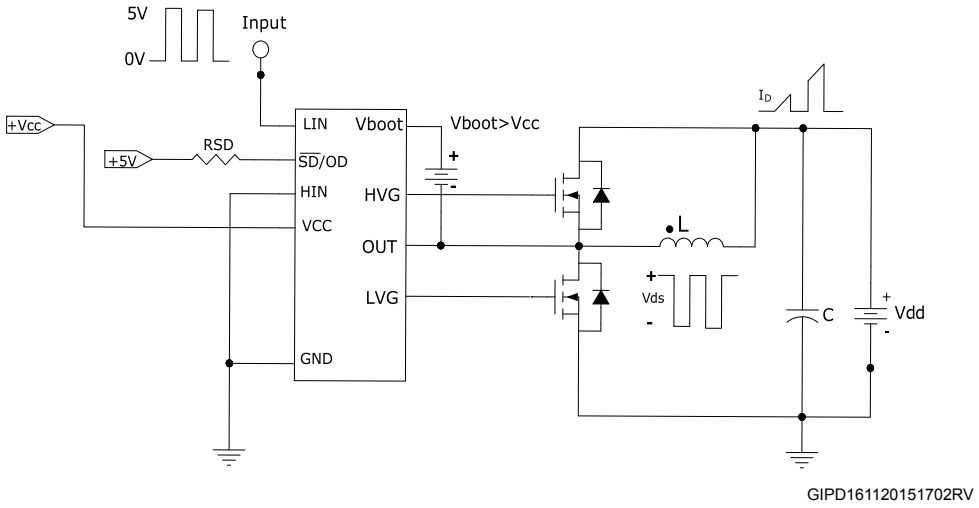


Figure 4. **Switching time definition**

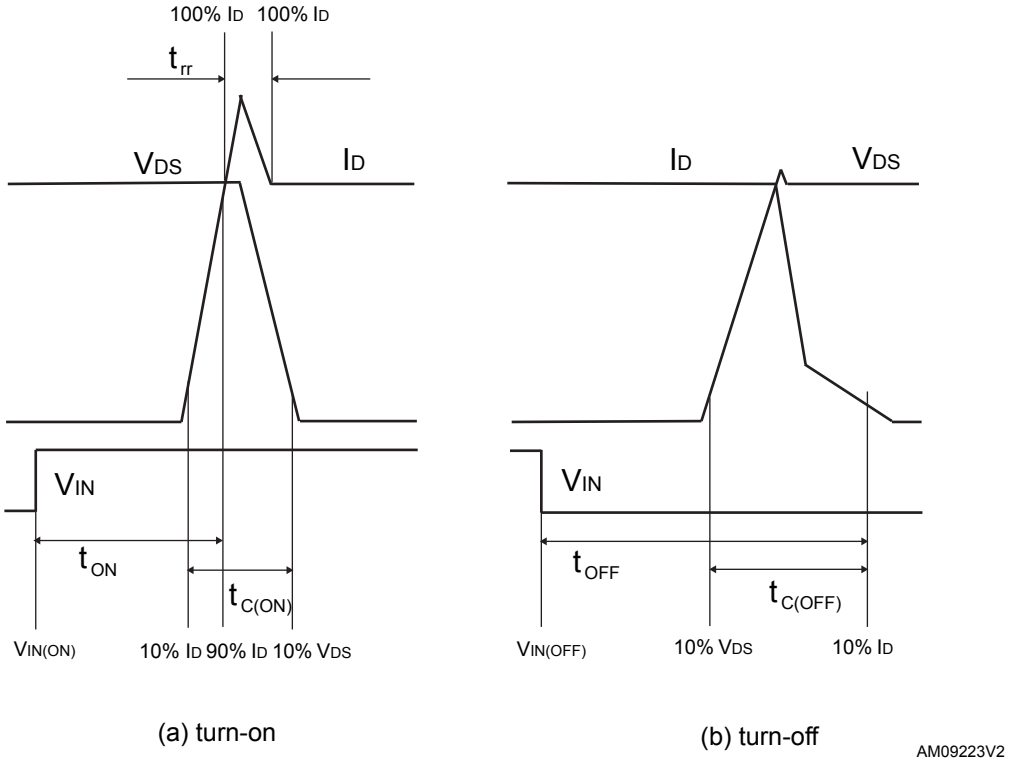


Figure 4. Switching time definition refers to HIN, LIN inputs (active high).

3.2 Control part

(V_{CC} = 15 V unless otherwise specified).

Table 8. Low voltage power supply

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{CC_hys}	V_{CC} UV hysteresis		1.2	1.5	1.8	V
V_{CC_thON}	V_{CC} UV turn-ON threshold		11.5	12	12.5	V
V_{CC_thOFF}	V_{CC} UV turn-OFF threshold		10	10.5	11	V
I_{qccu}	Undervoltage quiescent supply current	V_{CC} = 15 V, $\overline{SD}$/OD = 5 V, LIN = 0 V, HIN = 0 V, CIN = 0 V			150	µA
I_{qcc}	Quiescent current	V_{CC} = 15 V, $\overline{SD}$/OD = 5 V; LIN = 0 V; HIN = 0 V, CIN = 0 V			1	mA
V_{ref}	Internal comparator (CIN) reference voltage		0.5	0.54	0.58	V

Table 9. Bootstrapped voltage

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{BS_hys}	V_{BS} UV hysteresis		1.2	1.5	1.8	V
V_{BS_thON}	V_{BS} UV turn-ON threshold		11.1	11.5	12.1	V
V_{BS_thOFF}	V_{BS} UV turn-OFF threshold		9.8	10	10.6	V
I_{QBSU}	Undervoltage V_{BS} quiescent current	V_{BS} < 9 V, $\overline{SD}$/OD = 5 V, LIN = 0 V and HIN = 5 V; CIN = 0 V		70	110	µA
I_{QBS}	V_{BS} quiescent current	V_{BS} = 15 V, $\overline{SD}$/OD = 5 V, LIN = 0 V and HIN = 5 V; CIN = 0 V		200	300	µA
$R_{DS(on)}$	Bootstrap driver on-resistance	LVG ON		120		Ω

Table 10. Logic inputs

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{il}	Low logic level voltage				0.8	V
V_{ih}	High logic level voltage		2.25			V
I_{HINh}	HIN logic “1” input bias current	HIN = 15 V	20	40	100	µA
I_{HINl}	HIN logic “0” input bias current	HIN = 0 V			1	µA
I_{LINl}	LIN logic “1” input bias current	LIN = 15 V	20	40	100	µA
I_{LINh}	LIN logic “0” input bias current	LIN = 0 V			1	µA
I_{SDh}	$\overline{SD}$ logic “0” input bias current	$\overline{SD}$ = 15 V	30	120	300	µA
I_{SDl}	$\overline{SD}$ logic “1” input bias current	$\overline{SD}$ = 0 V			3	µA
Dt	Dead time	see Figure 5. Dead time and interlocking waveform definitions		180		ns

Table 11. Op-amp characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{io}	Input offset voltage	V_{ic} = 0 V, V_o = 7.5 V			6	mV
I_{io}	Input offset current	V_{ic} = 0 V, V_o = 7.5 V		4	40	nA
I_{ib}	Input bias current(1)			100	200	nA
V_{OL}	Low level output voltage	R_L = 10 kΩ to V_{CC}		75	150	mV
V_{OH}	High level output voltage	R_L = 10 kΩ to GND	14	14.7		V
I_o	Output short-circuit current	Source, V_{id} = +1 V; V_o = 0 V	16	30		mA
		Sink, V_{id} = -1 V; V_o = V_{CC}	50	80		mA
SR	Slew rate	V_i = 1 - 4 V; C_L = 100 pF; unity gain	2.5	3.8		V/µs
GBWP	Gain bandwidth product	V_o = 7.5 V	8	12		MHz
A_{vd}	Large signal voltage gain	R_L = 2 kΩ	70	85		dB
SVR	Supply voltage rejection ratio	vs. V_{CC}	60	75		dB
CMRR	Common mode rejection ratio		55	70		dB

1. *The direction of the input current is out of the IC.*

Table 12. Sense comparator characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{ib}	Input bias current	V_{CIN} = 1 V			1	µA
V_{od}	Open-drain low level output voltage	I_{od} = 3 mA			0.5	V
R_{ON_OD}	Open-drain low level output resistance	I_{od} = 3 mA		166		Ω
R_{PD_SD}	$\overline{SD}$ pull-down resistor(1)			125		kΩ
t_{d_comp}	Comparator delay	$\overline{SD}$/OD pulled to 5 V through 100 kΩ resistor		90	130	ns
SR	Slew rate	C_L = 180 pF; R_{pu} = 5 kΩ		60		V/µs
t_{sd}	Shutdown to high / low-side driver propagation delay	V_{OUT} = 0 V, V_{boot} = V_{CC}, V_{IN} = 0 to 3.3 V	50	125	200	ns
t_{isd}	Comparator triggering to high / low-side driver turn-off propagation delay	Measured applying a voltage step from 0 V to 3.3 V to pin CIN	50	200	250	

1. *Equivalent values as a result of the resistances of three drivers in parallel.*

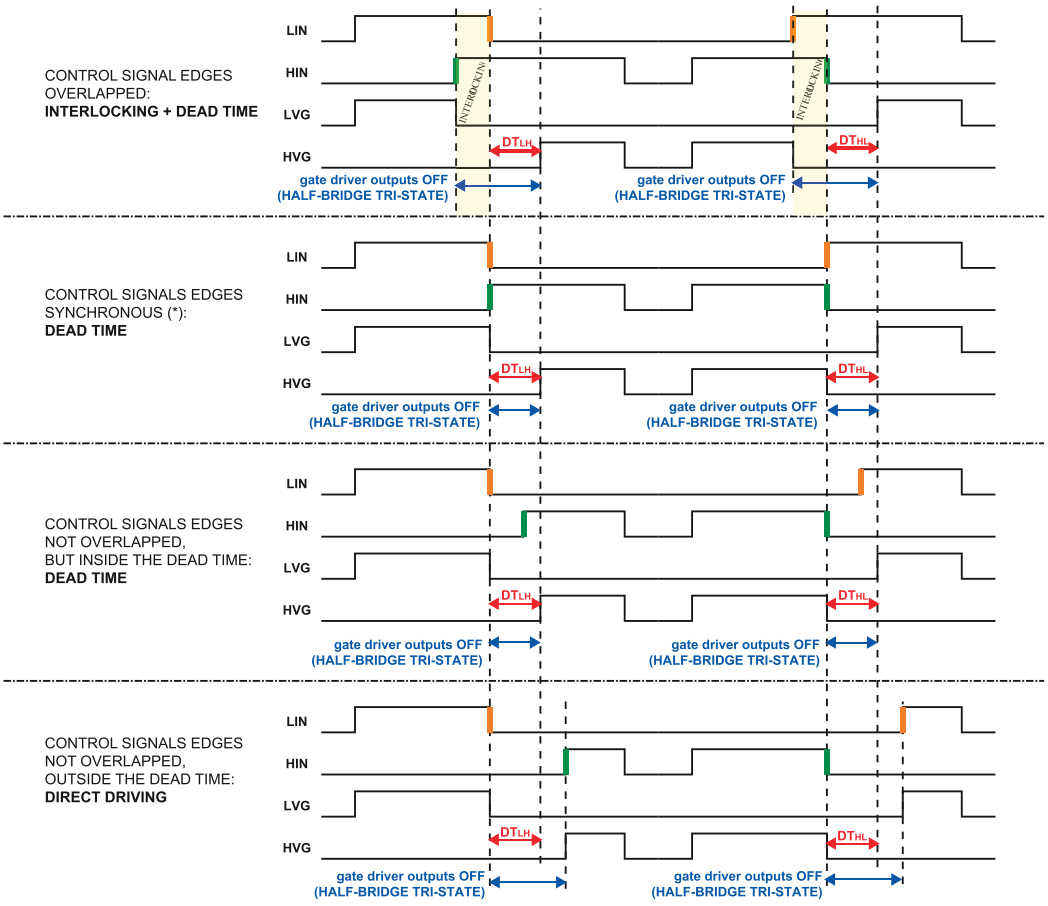
Table 13. Truth table

Conditions	Logic input (V_I)			Output	
	$\overline{SD}$/OD	LIN	HIN	LVG	HVG
Shutdown enable half-bridge tri-state	L	X(1)	X(1)	L	L
Interlocking half-bridge tri-state	H	H	H	L	L
0 “logic state” half-bridge tri-state	H	L	L	L	L
1 “logic state” low-side direct driving	H	H	L	H	L
1 “logic state” high-side direct driving	H	L	H	L	H

1. *X: do not care.*

3.3 Waveform definitions

Figure 5. Dead time and interlocking waveform definitions



4 Shutdown function

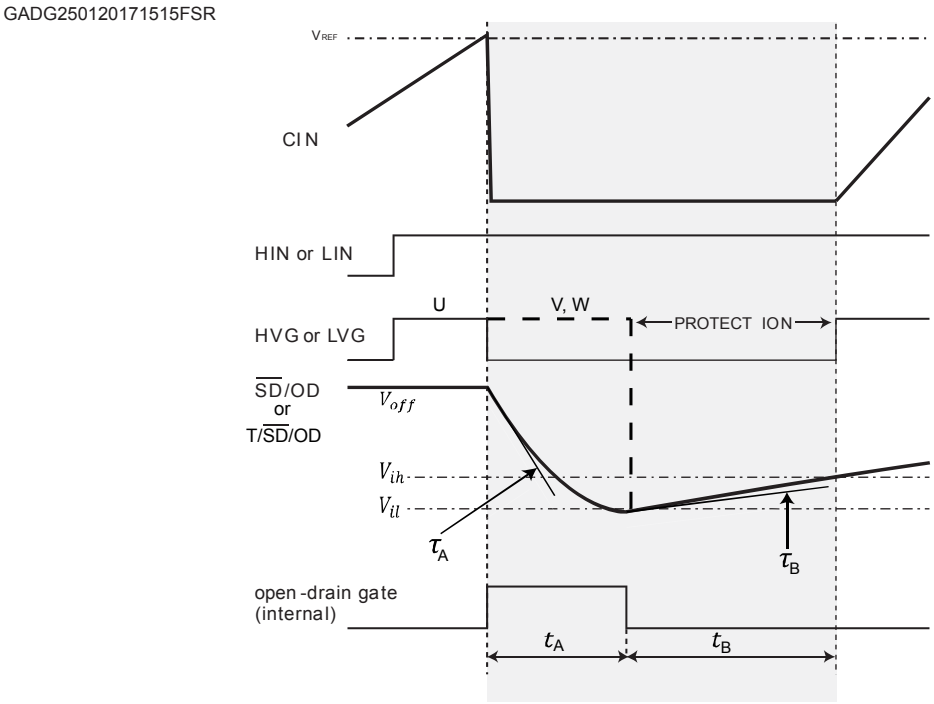
The device is equipped with three half-bridge IC gate drivers and integrates a comparator for fault detection.

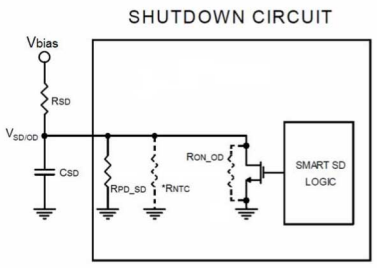
The comparator has an internal voltage reference V_{REF} connected to the inverting input, while the non-inverting input pin (CIN) can be connected to an external shunt resistor for current monitoring.

Since the comparator is embedded in the U IC gate driver, in case of fault it disables directly the U outputs, whereas the shutdown of V and W IC gate drivers depends on the RC value of the external SD circuitry, which fixes the disabling time.

For an effective design of the shutdown circuit, please refer to Application note AN4966.

Figure 6. Shutdown timing waveforms





$$t_A \cong \tau_A \cdot ln\left(\frac{V_{off} - V_{on}}{V_{il} - V_{on}}\right), \quad t_B \cong \tau_B \cdot ln\left(\frac{V_{il} - V_{off}}{V_{ih} - V_{off}}\right)$$

$$\tau_A = (R_{ON\_OD} // R_{SD} // R_{PD\_SD} // {}^*R_{NTC}) \cdot C_{SD} \cong R_{ON\_OD} \cdot C_{SD}$$

$$\tau_B = (R_{SD} // R_{PD\_SD} // {}^*R_{NTC}) \cdot C_{SD}$$

$$V_{on} = \frac{R_{ON\_OD} // R_{PD\_SD} // {}^*R_{NTC}}{(R_{ON\_OD} // R_{PD\_SD} // {}^*R_{NTC}) + R_{SD}} \cdot V_{bias} \cong \frac{R_{ON\_OD}}{R_{ON\_OD} + R_{SD}} \cdot V_{bias}$$

$$V_{off} = \frac{R_{PD\_SD} // {}^*R_{NTC}}{(R_{PD\_SD} // {}^*R_{NTC}) + R_{SD}} \cdot V_{bias}$$

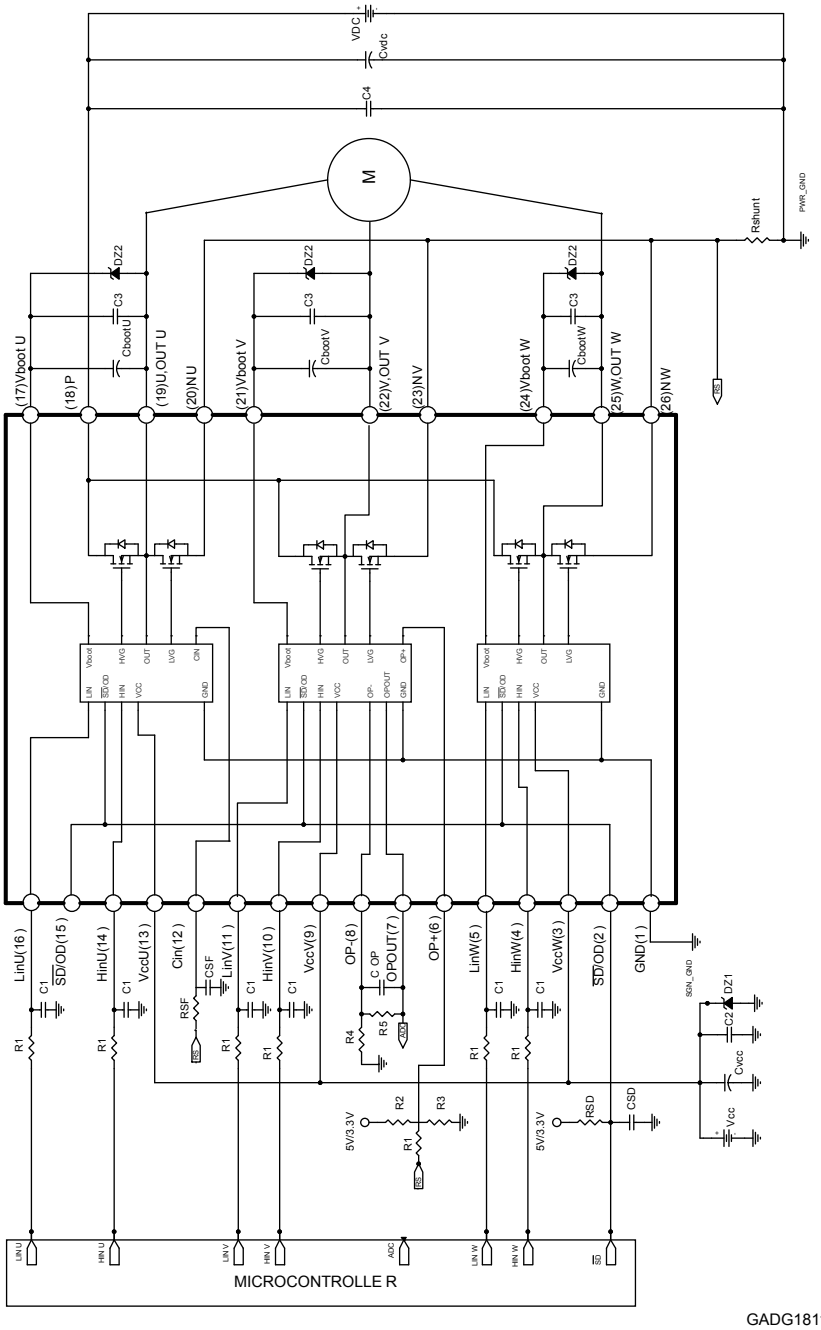
R_{SD} and C_{SD} external circuitry must be designed to ensure $V_{on} < V_{il}$ & $V_{off} > V_{ih}$

Please refer to AN4966 for further details.

* R_{NTC} to be considered only when the NTC is internally connected to the T/SD/OD pin.

5 Application circuit example

Figure 7. **Application circuit example**



Application designers are free to use a different scheme according to the specifications of the device.

5.1 Guidelines

- Input signals HIN, LIN are active high logic. A 375 kΩ (typ.) pull-down resistor is built-in for each input. To avoid input signal oscillation, the wiring of each input should be as short as possible, and the use of RC filters (R_1, C_1) on each input signal is suggested. The filters should be with a time constant of about 100 ns and placed as close as possible to the IPM input pins.
- The use of a bypass capacitor C_{VCC} (aluminum or tantalum) can reduce the transient circuit demand on the power supply. Also, to reduce any high-frequency switching noise distributed on the power lines, a decoupling capacitor C_2 (100 to 220 nF, with low ESR and low ESL) should be placed as close as possible to the V_{cc} pin and in parallel with the bypass capacitor.
- The use of an RC filter (R_{SF}, C_{SF}) is recommended to prevent protection circuit malfunction. The time constant (R_{SF} x C_{SF}) should be set to 1 µs and the filter must be placed as close as possible to the CIN pin.
- The $\overline{SD}$ is an input/output pin (open-drain type if it is used as output). The capacitor C_{SD} of the filter on $\overline{SD}$ should be fixed no higher than 3.3 nF in order to assure the $\overline{SD}$ activation time $\tau_A \leq 500$ ns. Besides, the filter should be placed as close as possible to the $\overline{SD}$ pin.
- The decoupling capacitor C_3 (from 100 to 220 nF, ceramic with low ESR and low ESL), in parallel with each C_{boot}, filters high-frequency disturbance. Both C_{boot} and C_3 (if present) should be placed as close as possible to the U, V, W and V_{boot} pins. Bootstrap negative electrodes should be connected to U, V, W terminals directly and separated from the main output wires.
- To avoid overvoltage on the V_{cc} pin, a Zener diode (Dz1) can be used. Similarly on the V_{boot} pin, a Zener diode (Dz2) can be placed in parallel with each C_{boot}.
- The use of the decoupling capacitor C_4 (100 to 220 nF, with low ESR and low ESL) in parallel with the electrolytic capacitor C_{vdc} is useful to prevent surge destruction. Both capacitors C_4 and C_{vdc} should be placed as close as possible to the IPM (C_4 has priority over C_{vdc}).
- By integrating an application-specific type HVIC inside the module, direct coupling to the MCU terminals without an opto-couplers is possible.
- Low-inductance shunt resistors have to be used for phase leg current sensing.
- In order to avoid malfunctions, the wiring on N pins, the shunt resistor and P_{WR_GND} should be as short as possible.
- The connection of SGN_GND to PWR_GND on one point only (close to the shunt resistor terminal) can reduce the impact of power ground fluctuation.

These guidelines ensure the specifications of the device for application designs. For further details, please refer to the relevant application note.

Table 14. Recommended operating conditions

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{PN}	Supply voltage	Applied between P-Nu, Nv, Nw		300	400	V
V_{CC}	Control supply voltage	Applied between V_{CC}-GND	13.5	15	18	V
V_{BS}	High-side bias voltage	Applied between V_{BOOTi}-OUT_i for i = U, V, W	13		18	V
t_{dead}	Blanking time to prevent arm-short	For each input signal	1			µs
f_{PWM}	PWM input signal	-40 °C < T_C < 100 °C -40 °C < T_J < 125 °C			25	kHz
T_C	Case operation temperature				100	°C

6 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

6.1 NDIP-26L type C package information

Figure 8. NDIP-26L type C package outline

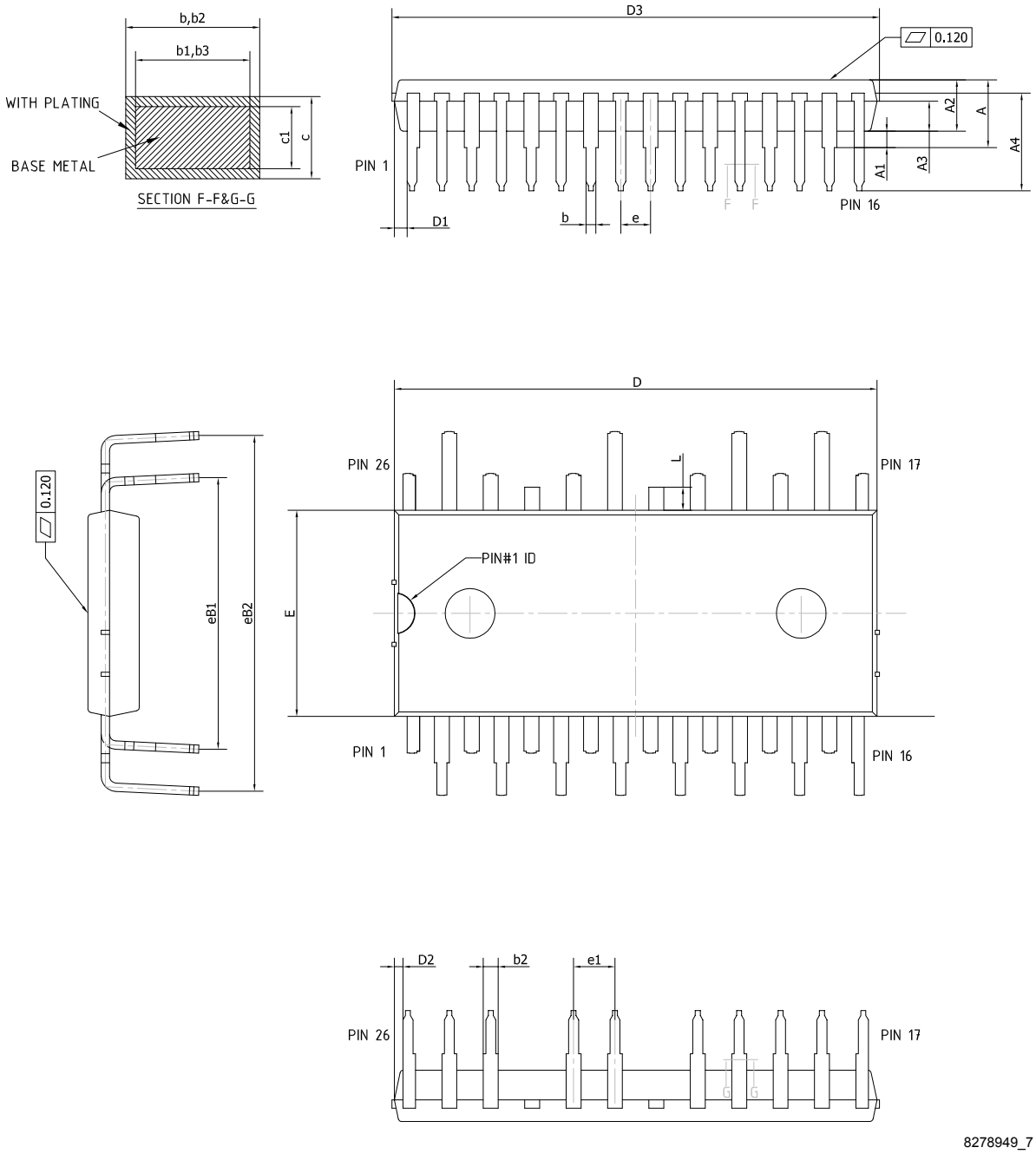


Table 15. **NDIP-26L type C mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A			4.40
A1	0.80	1.00	1.20
A2	3.00	3.10	3.20
A3	1.70	1.80	1.90
A4	5.70	5.90	6.10
b	0.53		0.72
b1	0.52	0.60	0.68
b2	0.83		1.02
b3	0.82	0.90	0.98
c	0.46		0.59
c1	0.45	0.50	0.55
D	29.05	29.15	29.25
D1	0.50	0.77	1.00
D2	0.35	0.53	0.70
D3			29.55
E	12.35	12.45	12.55
e	1.70	1.80	1.90
e1	2.40	2.50	2.60
eB1	16.10	16.40	16.70
eB2	21.18	21.48	21.78
L	1.24	1.39	1.54

6.2 NDIP-26L packing information

Figure 9. **NDIP-26L tube (dimensions are in mm)**

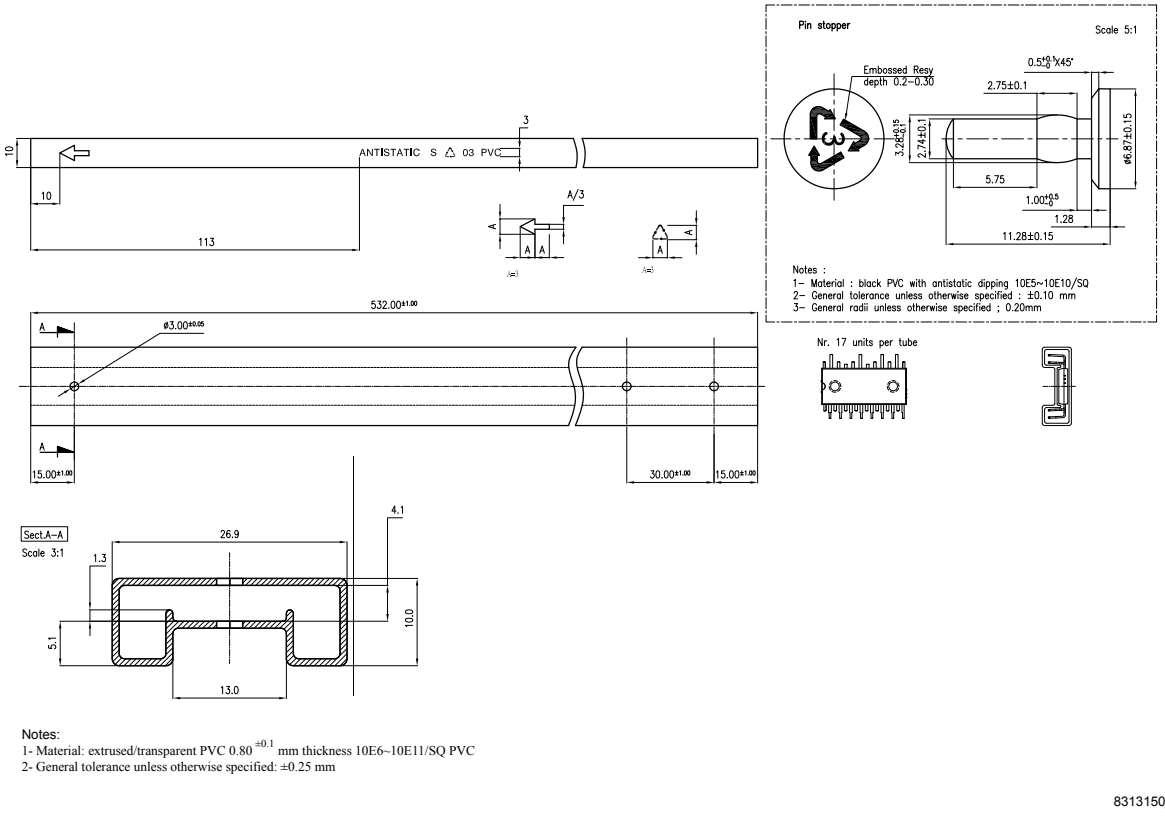


Table 16. **Shipping details**

Parameter	Value
Base quantity	17 pieces
Bulk quantity	476 pieces

Revision history

Table 17. **Document revision history**

Date	Revision	Changes
18-Nov-2016	1	Initial release.
25-Nov-2016	2	Datasheet promoted from preliminary data to production data.
05-Jan-2017	3	Modified *Table 8: "Inductive load switching time and energy"* Minor text changes
01-Feb-2017	4	Modified description on cover page
07-Jun-2017	5	Updated *Table 11: "Logic inputs (VCC = 15 V unless otherwise specified)"* and minor text changes.
28-Jan-2020	6	Updated title, cover image, Features and Applications in cover page. Updated Section 2 Electrical ratings. Updated Section 3.1 Inverter part and Section 3.2 Control part. Updated Section 4 Shutdown function. Updated Section 5.1 Guidelines. Minor text changes.

Contents